TOSHIBA Diode Silicon Epitaxial Planar Diode

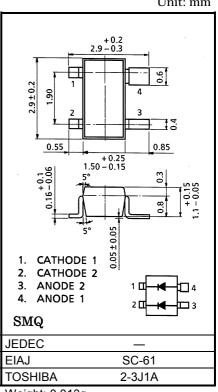
1SS399

High Voltage, High Speed Switching Applications

- Low forward voltage : $V_F = 1.0V$ (typ.)
- High voltage : $V_R = 400V$ (min.)
- Fast reverse recovery time: $t_{rr} = 0.5 \mu s$ (typ.) •
- Small total capacitance $: C_T = 2.5 pF (typ.)$
- : SC-61 • Small package

Maximum Ratings (Ta = 25°C)

Characteristic	Symbol	Rating	Unit
Maximum (peak) reverse Voltage	V _{RM}	420	V
Reverse voltage	V _R	400	V
Maximum (peak) forward current	I _{FM}	300 *	mA
Average forward current	Ι _Ο	100 *	mA
Surge current (10ms)	I _{FSM}	2 *	А
Power dissipation	Р	150 *	mW
Junction temperature	Tj	125	°C
Storage temperature range	T _{stg}	-55~125	°C



* : Unit rating. Total rating = unit rating \times 1.5

Weight: 0.013g

Electrical Characteristics (Ta = 25°C)

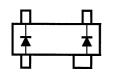
Characteristic	Symbol	Test Circuit	Test Condition	Min	Тур.	Max	Unit
Forward voltage	V _{F (1)}	_	I _F = 10mA	_	0.8	_	v
	V _{F (2)}	-	I _F = 100mA	-	1.0	1.3	
Reverse current	I _{R (1)}	-	V _R = 300V	-	_	0.1	μA
	I _{R (2)}	-	V _R = 400V	-	_	1.0	
Total capacitance	CT	_	V _R = 0, f = 1MH _z	_	2.5	5.0	pF
Reverse recovery time	t _{rr}	_	I _F = 10mA (Fig.1)	_	0.5	_	μs

Unit: mm

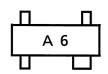


Equivalent Circuit (Top View)

Fig.1 Reverse Recovery Time (t_{rr}) Test Circuit

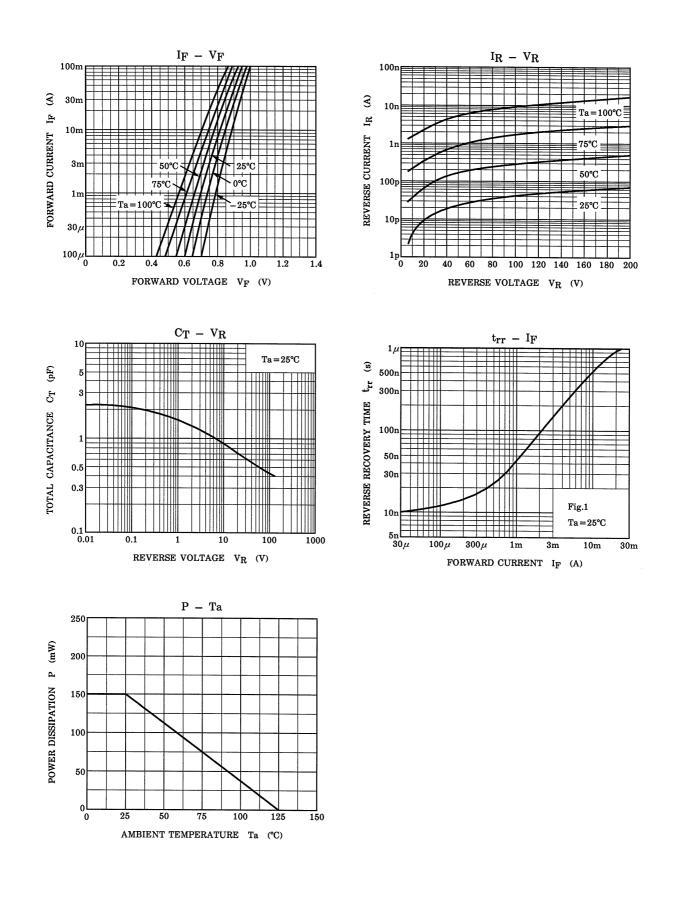


Marking



$-6V \xrightarrow{10\mu s}$ PULSE GENERATOR	OUTPUT W UTPUT IF=10mA 0 IF=10mA	
$(R_{OUT}=50\Omega)$	(RIN = 5012)	←−−−→

TOSHIBA



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